

> RoHS COMPLIANT

## N-Channel 40 V (D-S) MOSFET

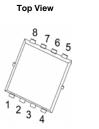
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	<b>R<sub>DS(on)</sub> (</b> Ω)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)		
40	0.0022 at V <sub>GS</sub> = 10 V	62	28 nC		
40	0.0038 at V <sub>GS</sub> = 4.5 V	35	20110		

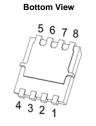
### **FEATURES**

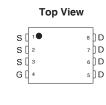
- TrenchFET II Power MOSFET
- + 100 %  $R_{\alpha}$  and UIS Tested

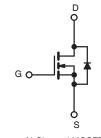
### **APPLICATIONS**

- Notebook PC Core
- VRM/POL









N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	40	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		62 <sup>a, e</sup>		
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>C</sub> = 70 °C		50 <sup>e</sup>	A	
	T <sub>A</sub> = 25 °C	I <sub>D</sub>	21 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		16 <sup>b, c</sup>		
Pulsed Drain Current		I <sub>DM</sub>	248	7	
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	58		
Single Pulse Avalanche Energy	L = 0.1 mm	E <sub>AS</sub>	135	mJ	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	62 <sup>a, e</sup>	A	
Commuted Source-Drain Diode Current	T <sub>A</sub> = 25 °C		35 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		92		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	PD	70	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	'D	6.3 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		4.1 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	ange	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	$t \le 10 \text{ s}$	R <sub>thJA</sub>	40	50	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	16	20		

Notes:

Notes: a. Based on  $T_C = 25$  °C. b. Surface mounted on 1" x 1" FR4 board. c. t = 10 s. d. Maximum under steady state conditions is 90 °C/W.

e. Calculated based on maximum junction temperature.

Parameter	Symbol	Test Conditions	Min .	Typ.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	40			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			35			
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 5.5		mV/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
		V <sub>DS</sub> = 32 V, V <sub>GS</sub> = 0 V			1	<u> </u>	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 32 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 V, V_{GS} = 10 V$	62			A	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.0022	0.0032	_	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 15 A		0.0038	0.0045	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 32V, I <sub>D</sub> = 10 A		70		S	
Dynamic <sup>b</sup>			<u>.</u>	1			
Input Capacitance	C <sub>iss</sub>			1950		pF	
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, f = 1 MHz		558			
Reverse Transfer Capacitance	C <sub>rss</sub>			52			
T + 1 0 + 01		$V_{DS} = 20 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$		28		nC	
Iotal Gate Charge	otal Gate Charge Q <sub>g</sub>			15			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 15 \text{ A}$		6			
Gate-Drain Charge	Q <sub>gd</sub>			3			
Gate Resistance	Rg	f = 1 MHz		1.5	2.5	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			15			
Rise Time	t <sub>r</sub>	$V_{DD}$ = 20 V, $R_L$ = 0.555 $\Omega$		10			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{D}\cong$ 20 A, $V_{GEN}$ = 10 V, $R_{g}$ = 1 $\Omega$		30			
Fall Time	t <sub>f</sub>			8			
Turn-On Delay Time	t <sub>d(on)</sub>			35		ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 20 V, $R_L$ = 0.625 $\Omega$		60			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 15 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		25			
Fall Time	t <sub>f</sub>			8			
Drain-Source Body Diode Characteristic	s			•			
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			62	А	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				248	~	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 12 A		0.7	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			50	75	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		63	95	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$F = 10 \text{ A}, \text{ and } r = 100 \text{ A/} \mu \text{s}, 1 \text{ J} = 25 \text{ C}$		21			
Reverse Recovery Rise Time	t <sub>b</sub>			20		ns	

Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



- 55 °C

2.0

24

20

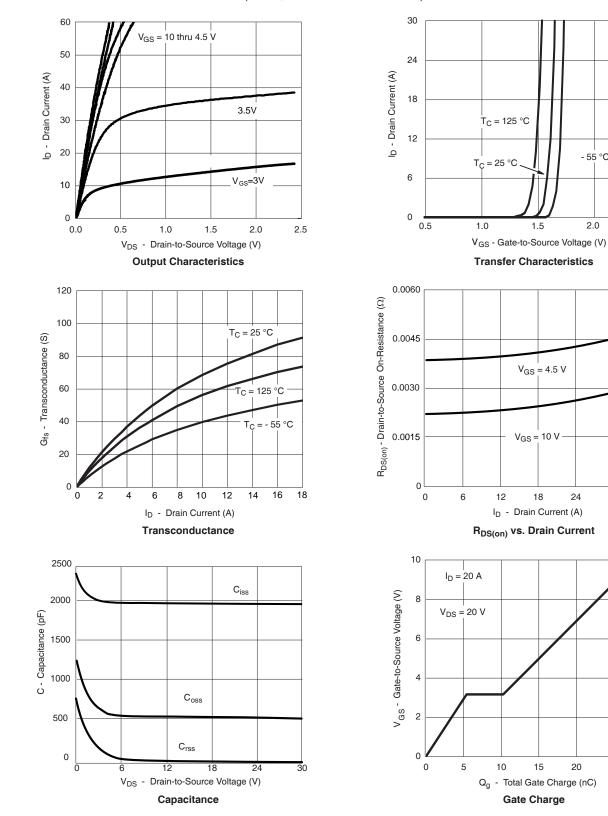
25

30

30

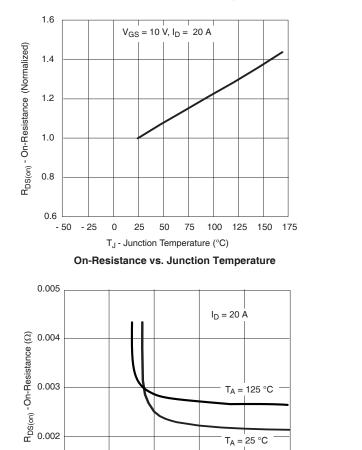
36

2.5



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



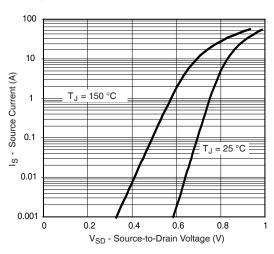


 $T_A = 25 \ ^\circ C$ 

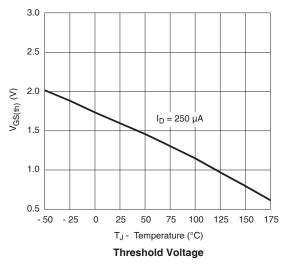
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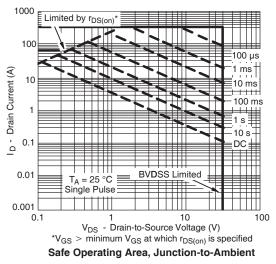
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#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Forward Diode Voltage vs. Temperature





0.001

0

2

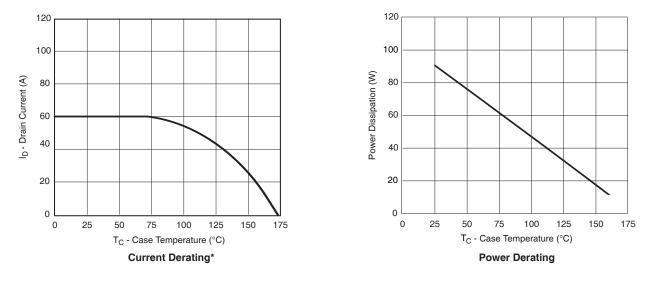
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V<sub>GS</sub> - Gate-to-Source Voltage (V)

R<sub>DS(on)</sub> vs. V<sub>GS</sub> vs. Temperature

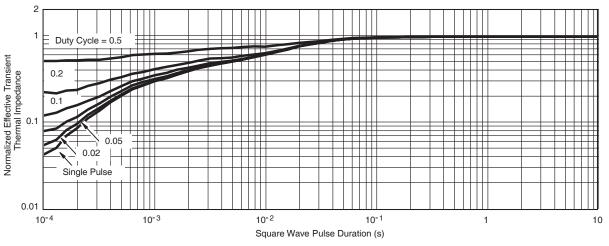
6





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

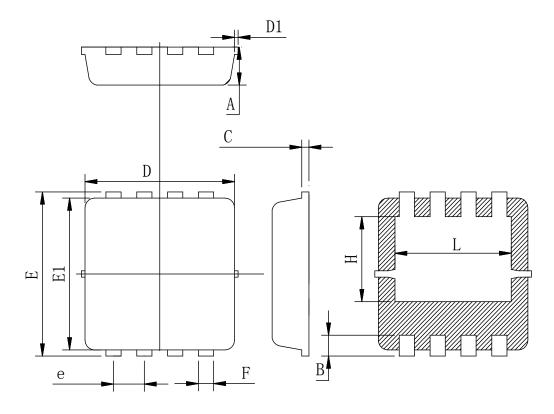
\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



Normalized Thermal Transient Impedance, Junction-to-Case



## PDFN 3.3X3.3 PACKAGE OUTLINE



## COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

Symbol	Min	Тур	Max
А	0.600	0.775	1.000
В	0.20	0.38	0.55
С	0.05	0.15	0.40
D	3.10	3.25	3.50
D1	-	-	0.15
Е	3.15	3.35	3.50
E1	2.60	3.10	3.45
e	0.50	0.65	0.80
F	0.15	0.32	0.45
Н	1.25	1.73	2.10
L	2.20	2.45	2.85



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